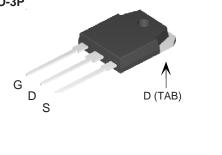


PRODUCT SUMMARY				
$V_{DS}$ (V) at $T_{J}$ max.	750			
R <sub>DS(on)</sub> typ. (Ω) at 25 °C	$V_{GS} = 10 V$	0.070		
Q <sub>g</sub> max. (nC)	278			
Q <sub>gs</sub> (nC)	46			
Q <sub>gd</sub> (nC)	76			
Configuration	Single			





#### FEATURES

- Fast body diode MOSFET using E series technology
- Reduced  $t_{rr},\,Q_{rr},\,and\,I_{RRM}$
- Low figure-of-merit (FOM):  $R_{on} \times Q_g$
- Low input capacitance (C<sub>iss</sub>)
- Low switching losses due to reduced Q<sub>rr</sub>
- Ultra low gate charge (Q<sub>g</sub>)
- Avalanche energy rated (UIS)

### APPLICATIONS

- Telecommunications
  - Server and telecom power supplies
- Lighting
  - High intensity discharge (HID)
  - Light emitting diodes (LEDs)
- Consumer and computing
- ATX power supplies
- Industrial

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N-Channel MOSFET

- Welding
- Battery chargers
- Renewable energy
  Solar (PV inverters)
- Switch mode power supplies (SMPS)
- Applications using the following topologies
  - LLC
  - Phase shifted bridge (ZVS)
  - 3-level inverter
  - AC/DC bridge

ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub> :	= 25 °C, unl	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V <sub>DS</sub>	700	V	
Gate-Source Voltage			V <sub>GS</sub>	± 30		
Continuous Drain Current (T <sub>J</sub> = 150 °C)	V <sub>GS</sub> at 10 V	$T_{\rm C} = 25 \ ^{\circ}{\rm C}$ $T_{\rm C} = 100 \ ^{\circ}{\rm C}$	- I <sub>D</sub> -	46		
	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 100 °C		29	А	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	154		
Linear Derating Factor				3.3	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	596	mJ	
Maximum Power Dissipation			PD	427	W	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C	
Drain-Source Voltage Slope	T <sub>J</sub> = 125 °C		70	70	V/ns	
Reverse Diode dV/dt <sup>d</sup>			dV/dt	5.3	v/ns	
Soldering Recommendations (Peak Temperature) <sup>c</sup>	for 10 s			300	°C	

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature.

b.  $V_{DD}$  = 140 V, starting T<sub>J</sub> = 25 °C, L = 28.2 mH, R<sub>g</sub> = 25  $\Omega$ , I<sub>AS</sub> = 6.5 A.

c. 1.6 mm from case.

d.  $I_{SD} \leq I_D,\,dI/dt$  = 100 A/µs, starting  $T_J$  = 25 °C.



COMPLIANT HALOGEN



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	40	°C/W	
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	0.3	0/10	

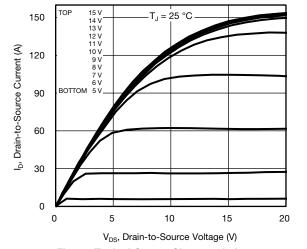
PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static	I					I	1
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> =	700	-	-	V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, $I_D = 10 \text{ mA}$		-	0.75	-	V/°C
Gate-Source Threshold Voltage (N)	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{GS} = \pm 20 V$		-	-	± 100	nA
			$V_{GS} = \pm 30 \text{ V}$	-	-	± 1	μA
Zero Gate Voltage Drain Current		$V_{DS} = 560 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$		-	-	1	μA
Zero Gale Voltage Drain Current	IDSS	V <sub>DS</sub> = 560 V	$V_{DS} = 560 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 125 ^{\circ}\text{C}$		-	500	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	$V_{GS} = 10 V$	I <sub>D</sub> = 22 A	-	0.070	-	Ω
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub>	= 30 V, I <sub>D</sub> = 22 A	-	17	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 V,$ $V_{DS} = 100 V,$ f = 1 MHz		-	5892	-	pF
Output Capacitance	C <sub>oss</sub>			-	244	-	
Reverse Transfer Capacitance	C <sub>rss</sub>			-	4	-	
Effective Output Capacitance, Energy Related <sup>a</sup>	C <sub>o(er)</sub>	$V_{\rm GS}$ = 0 V, $V_{\rm DS}$ = 0 V to 560 V		-	739	-	
Effective Output Capacitance, Time Related <sup>b</sup>	C <sub>o(tr)</sub>			-	178	-	
Total Gate Charge	Qg			-	185	278	
Gate-Source Charge	Q <sub>gs</sub>	$V_{GS} = 10 \text{ V}$ $I_D = 22 \text{ A}, V_{DS} = 560 \text{ V}$	-	46	-	nC	
Gate-Drain Charge	Q <sub>gd</sub>			-	76	-	1
Turn-On Delay Time	t <sub>d(on)</sub>			-	46	92	1
Rise Time	t <sub>r</sub>	$V_{DD} = 560 \text{ V}, \text{ I}_{D} = 22 \text{ A}$ $\text{R}_{g} = 9.1 \ \Omega, \text{ V}_{\text{GS}} = 10 \text{ V}$		-	77	116	- ns
Turn-Off Delay Time	t <sub>d(off)</sub>			-	157	236	
Fall Time	t <sub>f</sub>			-	100	150	
Gate Input Resistance	Rg	f = 1 MHz, open drain		0.2	0.5	1.0	Ω
Drain-Source Body Diode Characteristic	S						
Continuous Source-Drain Diode Current	۱ <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	46	
Pulsed Diode Forward Current	I <sub>SM</sub>			_	-	154	A
Diode Forward Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 22 A, V <sub>GS</sub> = 0 V		-	0.9	1.2	V
Reverse Recovery Time	t <sub>rr</sub>	$T_{J} = 25 \text{ °C}, I_{F} = I_{S} = 22 \text{ A},$ dl/dt = 100 A/ $\mu$ s, V <sub>R</sub> = 25 V		-	202	404	ns
Reverse Recovery Charge	Q <sub>rr</sub>			-	1.5	3.0	μC
Reverse Recovery Current	I <sub>BBM</sub>			-	14	-	A

### Notes

a.  $C_{oss(er)}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DS}$ . b.  $C_{oss(tr)}$  is a fixed capacitance that gives the charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DS}$ .

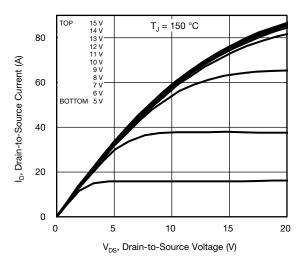
### **VBPB17R47S**





### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)







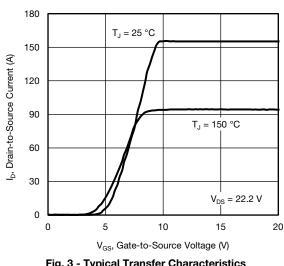


Fig. 3 - Typical Transfer Characteristics

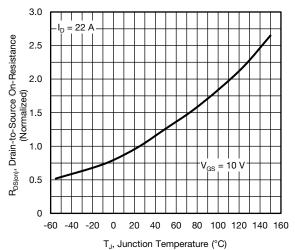


Fig. 4 - Normalized On-Resistance vs. Temperature

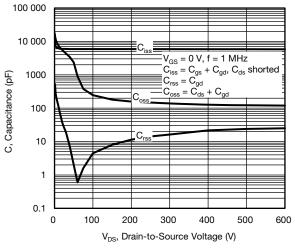
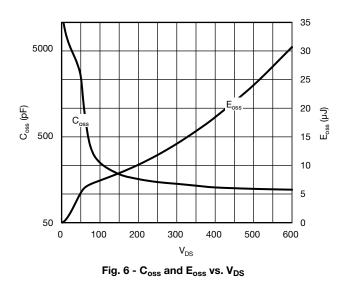


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage



### **VBPB17R47S**



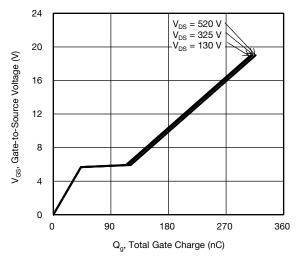


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

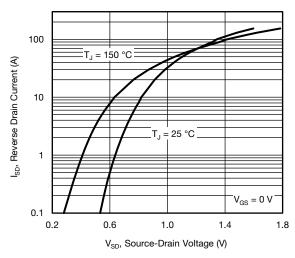
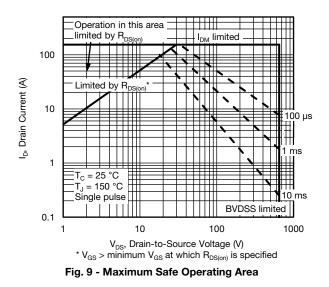


Fig. 8 - Typical Source-Drain Diode Forward Voltage



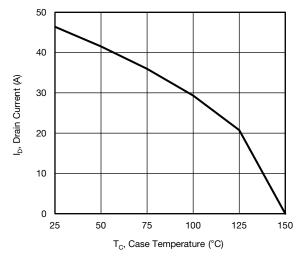


Fig. 10 - Maximum Drain Current vs. Case Temperature

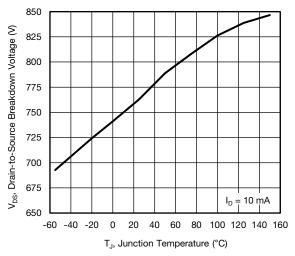
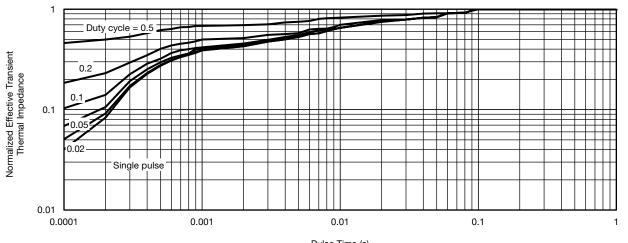


Fig. 11 - Typical Drain-to-Source Voltage vs. Temperature

### VBPB17R47S





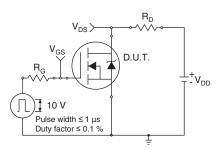


Fig. 13 - Switching Time Test Circuit

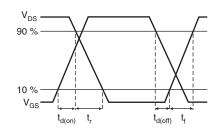


Fig. 14 - Switching Time Waveforms

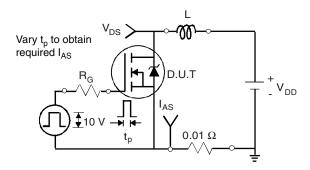


Fig. 15 - Unclamped Inductive Test Circuit

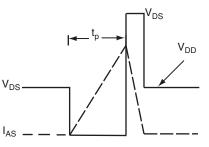


Fig. 16 - Unclamped Inductive Waveforms

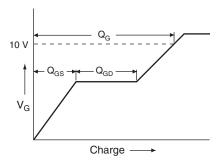


Fig. 17 - Basic Gate Charge Waveform

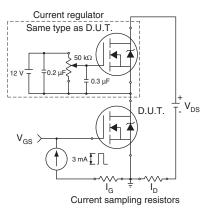


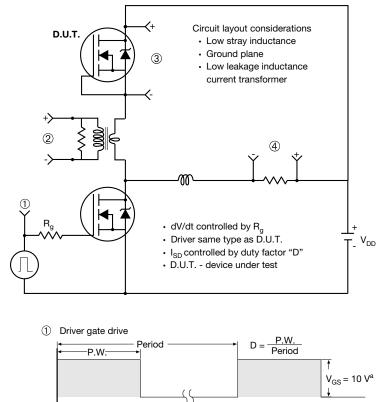
Fig. 18 - Gate Charge Test Circuit

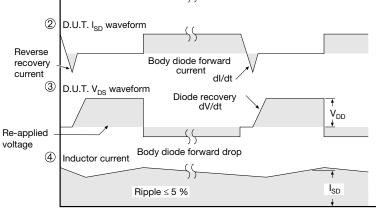
Bsemi

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### Peak Diode Recovery dV/dt Test Circuit





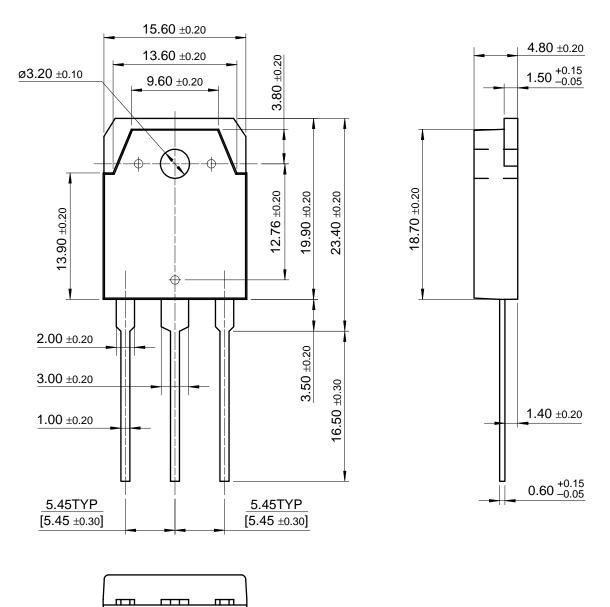
Note

a.  $V_{GS}$  = 5 V for logic level devices

Fig. 19 - For N-Channel



TO-3P



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